

<b>Notice of References Cited</b>	Application/Control No. 10/585,047		Applicant(s)/Patent Under Reexamination LUTZ ET AL.	
	Examiner JOHN K. KIM		Art Unit 2834	Page 1 of 1

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*	C	US-5,708,318	01-1998	Fudono, Kiyoshi	310/263
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#### NON-PATENT DOCUMENTS

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